

Notice of References Cited	Application/Control No. 10/005,064	Applicant(s)/Patent Under Reexam Campbell et al.	
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	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	Kozakiewicz, Chem. Abstract 130:267406, 1999.
V	Pomarnacka et al., Chem. Abstract 130:153642, 1998.
W	Kelarev et al., Chem. Abstract 130:68841, 1998.
X	Silin et al., Chem. Abstract 129:260428, 1998.

^{*} A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

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